

<b>Notice of References Cited</b>	Application/Control No. 10/779,367	Applicant(s)/Patent Under Reexamination ENOCH ET AL.	
	Examiner Mark Spisich	Art Unit 1744	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,634,052	10-2003	Hanson, Mark A.	15/220.2
	C	US-			
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	F	US-			
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

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#### NON-PATENT DOCUMENTS

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	U	Derwent-Acc-No 2004-035881 related to CN 1448103 A, published 15 October 2003.
	V	Derwent-Acc-No 1979-C1558B related to SU 603370 A, published 29 March 1978.
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	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.